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29 July 2009

Online at https://mpra.ub.uni-muenchen.de/16528/ MPRA Paper No. 16528, posted 02 Aug 2009 02:12 UTC

Bayes Reliability Measures of Lognormal and Inverse Gaussian distributions under ML-II \(\varepsilon\)-contaminated class of prior distributions

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Abstract

In this paper we employ ML-II ε -contaminated class of priors to study the sensitivity of Bayes Reliability measures for an Inverse Gaussian (IG) distribution and Lognormal (LN) distribution to misspecification in the prior. The numerical illustrations suggest that reliability measures of both the distributions are not sensitive to moderate amount of misspecification in prior distributions belonging to the class of ML-II ε -contaminated.

1. Introduction

Bayes reliability methods utilize objective test data and investigator's subjective information to evaluate new complex devices. An evolutionary system design depends heavily on subjectively held notions of reliability.

Robust Bayesian viewpoint assumes only that subjective information can be quantified in terms of a class of possible distributions. Any analysis, therefore, based on a single convenient prior is questionable. A reasonable approach (see Berger [1984, 1985, 1990, 1994]) is to consider a class of plausible priors that are in the neighborhood of a specific assessed approximation to the "true" prior and examine the robustness of the decision with respect to this class of prior distributions.

Though the MCMC method freed the analysts from using the conjugate prior for mathematical convenience but the problem still remains; how to eliminate the subjectivity involved in choosing a prior distribution?

The ε-contaminated class of prior distributions has attracted attention of a number of authors to model uncertainty in the prior distribution. Berger and Berliner (1986) used Type II maximum likelihood technique (cf. Good, 1965) to select a robust prior from ε-contaminated class of prior distributions having the form:

$$\Gamma = \left\{ \pi(\theta) = (1 - \varepsilon) \, \pi_o + \varepsilon \, \, q \, \, , \, \, q \in Q \right\}$$

Here, π_o is the true assessed prior and q, being a contamination, belongs to the class Q of all distributions. Q determines the allowed contaminations that are mixed with π_o , and $\varepsilon \in [0,1]$ reflects the amount of uncertainty in the 'true' prior π_o . ML-II technique would naturally select a prior with a large tail which would be robust against all plausible deviations. Sinha and Bansal (2008) used ε -contaminated class of prior for the problem of optimization of a regression nature in the decisive prediction framework.

The selection of the maximum likelihood type-II technique requires a robust prior π in the class Γ of priors, which maximizes the marginal $m(\underline{t} \mid a)$. For

$$\pi(\theta) = (1 - \varepsilon)\pi_{\alpha}(\theta) + \varepsilon q(\theta) \; ; \; \hat{q} \in Q$$

the marginal of x

$$m(\underline{t} \mid \pi) = (1 - \varepsilon)m(\underline{t} \mid \pi_{o}) + \varepsilon m(\underline{t} \mid q)$$

can be maximized by maximizing it over Q. Let the maximum of $m(\underline{x}|q)$ be attained at unique $\hat{q} \in Q$. Thus an estimated ML-II prior $\hat{\pi}(\theta)$ is given by

$$\hat{\pi}(\theta) = (1 - \varepsilon)\pi_{o}(\theta) + \varepsilon \hat{q}(\theta)$$

The lognormal (LN) distribution is often useful in the analysis of economic, biological and life testing data. It can often be used to fit data that have large range of values. The lognormal distribution is commonly used for modeling asset prices, general reliability analysis, cycles-to-failure in fatigue, material strengths and loading variables in probabilistic design (see Aitchison and Brown (1957)). However, sometimes the lognormal distribution does not completely satisfy the fitting expectation in real situation, in such situations the use of generalized form of lognormal distribution is suggested. Martín and Pérez (2009) analyzed a generalized form of lognormal distribution from a Bayesian point of view. Martz and Waller (1982) and Blishke and Murthy (2000) present excellent theory and applications of reliability analysis.

The two-parameter inverse Gaussian (IG) distribution, as a first passage time distribution in Brownian motion, found a variety of applications in the life testing, reliability and financial modeling problems. It has statistical properties analogous to normal distribution. Banerjee and Bhattacharyya (1976) applied the IG distribution to consumer panel data on toothpaste purchase incidence for the assessment of consumer heterogeneity. Whitemore (1976, 1986) discusses the potential applications of IG distribution in the management sciences and illustrates the advantages of IG distribution for right-skewed positive valued responses and its applicability in stochastic model for many real settings. Aase (2000) showed that IG distribution fits the economic indices remarkably well in empirical investigations. Nadarajah and Kotz (2007) gave the distribution of ratio of two economic indices each having IG distribution for comparing the consumer price indices of six major economies.

Excellent monograph by Chhikara and Folks (1989) and Seshadri (1999) contain bibliographies and survey of the literature on IG distribution. Banerjee & Bhattacharyya (1979) considered the normal distribution, truncated at zero, as a natural conjugate prior for the parameter θ of IG(θ , λ), while exploring the Bayesian results for IG distribution.

In the subsequent sections, we employ ML-II ε -contaminated class for the parameter θ of IG(θ , λ), shape parameter λ known, and $LN(\theta,\psi)$, ψ known, to study sensitivity of Bayes reliability measures to misspecification in the prior distribution.

2. Lognormal Distribution

The probability density function (pdf) of lognormal distribution is expressed as

$$p(t \mid \theta, \psi) = \left(\frac{\psi}{2\pi}\right)^{1/2} t^{-1} \exp\left[-\frac{\psi}{2} \left(\ln(t) - \theta\right)\right], \ t > 0, \ -\infty < \theta < \infty, \ \psi > 0$$
 (2.1)

where ψ is known and ln(t) is the natural log of t, we designate equation (2.1) by $LN(\theta,\psi)$. Let $\underline{t} = (t_1,...,t_2)$ be n independent complete failure times from $LN(\theta,\psi)$. The likelihood function is given by

$$L(\theta \mid \underline{t}, \psi) = \left(\frac{\psi}{2\pi}\right)^{\frac{n}{2}} \prod_{i=1}^{n} t_i^{-1} \exp\left[-\frac{\psi v}{2} - \frac{n\psi}{2} (\theta - \overline{z})^2\right]$$
 (2.2)

where $v = \sum_{i=1}^{n} (\ln(t_i) - \overline{z})$ and $\overline{z} = \sum_{i=1}^{n} \ln(t_i) / n$.

The reliability for a time period of time t_0 is

$$r(t_o; \theta, \psi) = P(T > t_o) = \int_{t_o}^{\infty} p(t \mid \theta, \psi) dt = 1 - \Phi\left(\sqrt{\psi} \left(\ln(t_o) - \theta\right)\right)$$
 (2.3)

 $\Phi(\cdot)$ denotes standard normal cdf. Suppose θ has a prior distribution belonging to ML-II ε-contaminated class of priors. Following Berger and Berliner (1986), we have $\pi_o(\theta)$ as $N(\mu,\tau)$ and $\hat{q}(\theta)$ as $Uniform(\mu-\hat{a},\mu+\hat{a})$, \hat{a} being the value of 'a' which maximizes

$$m(\underline{t} \mid a) = \begin{cases} \frac{1}{2a} \int_{\mu-a}^{\mu+a} L(\theta \mid \underline{t}, \psi) d\theta & a > 0 \\ L(\mu \mid t, \psi) & a = 0 \end{cases}$$

 $m(t \mid a)$ is an upper bound on $m(t \mid q)$.

$$m(\underline{t} \mid a) = \left(\frac{\psi}{2\pi}\right)^{\frac{n}{2}} \prod_{i=1}^{n} t_i^{-1} e^{-\frac{\psi v}{2}} \sqrt{\frac{2\pi}{n\psi}} \frac{1}{2a} \int_{\mu-a}^{\mu+a} \sqrt{\frac{n\psi}{2\pi}} \exp\left[-\frac{n\psi}{2} (\theta - \overline{z})^2\right] d\theta$$
$$= \frac{C}{2a} \left\{ \Phi\left[\sqrt{n\psi} \left(\mu + a - \overline{z}\right)\right] - \Phi\left[\sqrt{n\psi} \left(\mu - a - \overline{z}\right)\right] \right\}$$
(2.4)

where $C = \left(\frac{\psi}{2\pi}\right)^{\frac{n}{2}} \prod_{i=1}^{n} t_i^{-1} e^{-\frac{\psi v}{2}} \sqrt{\frac{2\pi}{n\psi}}$. On differentiating equation (2.4) with respect to a, we have

$$\frac{d}{da}m(\underline{t}|a) = -\frac{C}{2a^2} \left\{ \Phi\left[\sqrt{n\psi}(\mu + a - \overline{z})\right] - \Phi\left[\sqrt{n\psi}(\mu - a - \overline{z})\right] \right\} + \frac{C\sqrt{n\psi}}{2a} \left\{ \phi\left[\sqrt{n\psi}(\mu + a - \overline{z})\right] + \phi\left[\sqrt{n\psi}(\mu - a - \overline{z})\right] \right\}$$

where $\phi(\cdot)$ denotes standard normal pdf. (2.5)

Now we substitute $\omega = \sqrt{n\psi} |\overline{z} - \mu|$ and $a^* = a\sqrt{n\psi}$ in (2.5) and equate to zero. The equation becomes

$$\Phi(a^* - \omega) - \Phi[-(a^* + \omega)] = a^* \{ \phi(a^* - \omega) + \phi[-(a^* + \omega)] \}$$

which can be written as

$$a^* = \omega + \left\{ -2\log \left[\sqrt{2\pi} \left(\frac{1}{a^*} \left[\Phi(a^* - \omega) - \Phi[-(a^* + \omega)] \right] - \phi[-(a^* + \omega)] \right] \right\}^{\frac{1}{2}}$$
 (2.6)

Solving (2.6) by standard fixed-point iteration, set $a^* = \omega$ on the right-hand side, which gives

$$\widehat{a} = \begin{cases} 0 & \text{if } \omega \le 1.65 \\ \frac{a^*}{\sqrt{n\psi}} & \text{if } \omega > 1.65 \end{cases}$$

Following Berger and Sellke (1987), we make \hat{a} equal to zero when \bar{t} is close to μ .

The usual Bayes point estimate \hat{r} , under quadratic loss function, is the posterior mean of $r(t_o; \theta, \psi)$

$$\widehat{r} = \int_{\Theta} r(t_o; \theta, \psi) \pi(\theta \mid \underline{t}, \psi) d\theta$$
(2.7)

where posterior distribution $\pi(\theta \mid t, \psi)$ of parameter θ with respect to prior $\pi(\theta)$ is given by

$$\pi(\theta \mid \underline{t}, \psi) = \frac{L(\theta \mid \underline{t}, \psi)\pi(\theta)}{\lambda(\underline{t}) \int_{\Theta} L(\theta \mid \underline{t}, \psi)\pi_o(\theta)d\theta + (1 - \lambda(\underline{t})) \int_{\Theta} L(\theta \mid \underline{t}, \psi)q(\theta)d\theta}$$

$$= \frac{L(\theta \mid \underline{t}, \psi)\pi(\theta)}{\lambda(\underline{t})m(\underline{t} \mid \pi_o) + (1 - \lambda(\underline{t}))m(\underline{t} \mid q)} = \lambda(\underline{t})\pi_o(\theta \mid \underline{t}) + (1 - \lambda(\underline{t}))q(\theta \mid \underline{t}) \qquad (2.8)$$

where

$$m(\underline{t} \mid \pi_{o}) = C'e^{-\gamma} \quad ; \quad C' = \left(\frac{\psi}{2\pi}\right)^{\frac{1}{2}} \prod_{i=1}^{n} t_{i}^{-1} \sqrt{\frac{\tau}{\tau'}} \quad ; \quad \tau' = \tau + n\psi$$

$$m(\underline{t} \mid q) = \frac{C}{2\hat{a}} \hat{\phi}_{1} \quad ; \quad \hat{\phi}_{1} = \Phi\left[\sqrt{n\psi} \left(\mu + \hat{a} - \overline{z}\right)\right] - \Phi\left[\sqrt{n\psi} \left(\mu - \hat{a} - \overline{z}\right)\right],$$

$$\pi_{o}(\theta \mid \underline{t}) = \frac{L(\theta \mid \underline{t}, \psi)\pi_{o}(\theta)}{m(\underline{t} \mid \pi_{o})} = \sqrt{\frac{\tau'}{2\pi}} \exp\left[-\frac{\tau'}{2}(\theta - \mu')^{2}\right] \quad ; \quad \mu' = \frac{\tau\mu + n\psi\overline{z}}{\tau'}$$

$$q(\theta \mid \underline{t}) = \frac{L(\theta \mid \underline{t}, \psi)q(\theta)}{m(\underline{t} \mid q)} = \frac{1}{\hat{\phi}_{1}} \sqrt{\frac{n\psi}{2\pi}} \exp\left[-\frac{n\psi}{2} \left(\theta - \overline{z}\right)^{2}\right],$$

$$\lambda(\underline{t}) = \left[1 + \frac{\varepsilon m(\underline{t} \mid q)}{(1 - \varepsilon)m(\underline{t} \mid \pi_{o})}\right]^{-1} = \left[1 + \frac{\varepsilon}{(1 - \varepsilon)} \left(\frac{n\psi\tau}{2\pi\tau'}\right)^{-\frac{1}{2}} \frac{\hat{\phi}_{1}e^{\gamma'}}{2\hat{a}}\right]^{-1},$$

$$\gamma = \gamma' + \frac{\psi\nu}{2} \quad \text{and} \quad \gamma' = \frac{n\psi\tau}{2\tau'} \left(\mu - \overline{z}\right)^{2}.$$

thus equation (2.7) becomes

$$\widehat{r} = \int_{-\infty}^{\infty} \int_{t_o}^{\infty} \left(\frac{\psi}{2\pi}\right)^{\frac{1}{2}} t^{-1} \exp\left[-\frac{\psi}{2} \left(\ln(t) - \theta\right)^{2}\right] \pi_{o}(\theta \mid \underline{t}) dt d\theta + \int_{\mu - \overline{a}}^{\mu + \overline{a}} \int_{t_o}^{\infty} \left(\frac{\psi}{2\pi}\right)^{\frac{1}{2}} t^{-1} \exp\left[-\frac{\psi}{2} \left(\ln(t) - \theta\right)^{2}\right] q(\theta \mid \underline{t}) dt d\theta$$

$$= \lambda(\underline{t}) \left\{1 - \Phi\left[\sqrt{\tau''} \left(\ln(t_o) - \mu'\right)\right]\right\} + \frac{(1 - \lambda(\underline{t}))}{\widehat{\phi}_{1}} \left(\frac{n\psi}{2\pi(n+1)}\right)^{\frac{1}{2}} \int_{t_o}^{\infty} t^{-1} \exp\left[-\frac{n\psi}{2(n+1)} \left(\ln(t) - \overline{z}\right)^{2}\right] \phi(\underline{t}) dt$$
where
$$\phi(\underline{t}) = \Phi\left[\sqrt{\psi(n+1)} \left(\mu + \overline{a} - \mu_{1}\right)\right] - \Phi\left[\sqrt{\psi(n+1)} \left(\mu - \overline{a} - \mu_{1}\right)\right]; \quad \mu_{1} = \frac{\ln(t) + n\overline{z}}{n+1}, \quad \tau'' = \frac{r\tau'}{r+\tau'}$$

$$(2.9)$$

We use numerical integration in order to evaluate the incomplete integral in equation (2.9).

Lower one-sided Bayes Probability Interval (LBPI) Estimate

Reliability analysts are sometimes interested in $100(1-\alpha)\%$ LBPI estimate r_* of $r(t_o)$ where α is chosen to be a small quantity. Bayesian estimate of $r(t_o)$ is easily constructed from the corresponding interval for θ as follows

$$P(\theta \le \theta_* \mid t, \psi) = \alpha \tag{2.10}$$

Since $r(t_o; \theta, \psi)$ is a monotonically non-decreasing function of θ , we have the LBPI estimate of $r(t_o)$ as

$$P(\theta \le \theta_* \mid \underline{t}, \psi) = P(R(t_o) \le 1 - \Phi(\sqrt{\psi}(\ln(t_o) - \theta_*)) \mid \underline{t}, \psi) = \alpha$$

Thus $100(1-\alpha)\%$ LBPI estimate of $r(t_a)$ is given as

$$r_* = 1 - \Phi\left(\sqrt{\psi}\left(\ln(t_o) - \theta_*\right)\right) \tag{2.11}$$

where θ_* is the 100(1- α)% LBPI estimate of θ and is evaluated as

$$\int_{\Theta}^{\theta_{*}} \pi(\theta \mid \underline{t}, \psi) d\theta = \alpha$$

$$\lambda(\underline{t}) \int_{-\infty}^{\theta_{*}} \pi_{o}(\theta \mid \underline{t}) d\theta + (1 - \lambda(\underline{t})) \int_{\mu - \widehat{a}}^{\theta_{*}} q(\theta \mid \underline{t}) d\theta = \alpha$$

$$\lambda(\underline{t}) \Phi\left(\sqrt{\tau'}(\theta_{*} - \mu')\right) + \frac{(1 - \lambda(\underline{t}))}{\widehat{\theta_{*}}} \Phi\left(\sqrt{n\psi}\left(\theta_{*} - \overline{z}\right)\right) = \alpha + \frac{(1 - \lambda(\underline{t}))}{\widehat{\theta_{*}}} \Phi\left(\sqrt{n\psi}\left(\mu - \widehat{a} - \overline{z}\right)\right)$$

We evaluate θ_* using Matlab for a given α and substitute in (2.11) to obtain the required LBPI estimates for various levels of contamination in the prior.

Reliable Life

The reliable life is the time t_R for which the reliability will be R. It may be considered as the time t_R for which 100R% of population will survive. The determination of t_R is same as computing the 100(1-R)th percentile of the failure time distribution. For a $LN(\theta, \psi)$ population

$$t_R = \exp(\psi^{-1/2}\Phi^{-1}(1-R) + \theta)$$

For known ψ , t_R is the linear function of θ . The Bayes estimate of t_R , under quadratic loss function, is the posterior expected value of t_R

$$\begin{split} t_{R} &= E^{\pi(\theta|\underline{t},\psi)} \left[\exp\left(\psi^{-1/2}\Phi^{-1}(1-R) + \theta\right) \right] = \exp\left(\psi^{-1/2}\Phi^{-1}(1-R)\right) \int_{\Theta} e^{\theta} \pi(\theta \mid \underline{t},\psi) d\theta \\ &= \lambda(\underline{t}) \int_{-\infty}^{\infty} e^{\theta} \pi_{o}(\theta \mid \underline{t}) d\theta + (1-\lambda(\underline{t})) \int_{\mu-\bar{a}}^{\mu+\bar{a}} e^{\theta} q(\theta \mid \underline{t}) d\theta \\ &= \lambda(\underline{t}) \exp\left(\mu' + \frac{1}{2\tau'}\right) + \frac{(1-\lambda(\underline{t}))}{\hat{\theta_{h}}} \exp\left(\overline{z} + \frac{1}{2n\psi}\right) \left[\Phi(h) - \Phi(g)\right] \end{split} \tag{2.12}$$

where

$$h = \sqrt{n\psi} (\mu + \hat{a} - \overline{z}) - \frac{1}{\sqrt{n\psi}}$$
 and $g = \sqrt{n\psi} (\mu - \hat{a} - \overline{z}) - \frac{1}{\sqrt{n\psi}}$

3. Inverse Gaussian Distribution

The probability density function (pdf) of IG distribution is expressed as

$$p(t \mid m, \lambda) = \left(\frac{\lambda}{2\pi}\right)^{1/2} t^{-3/2} \exp\left[-\frac{\lambda (t-m)^2}{2m^2 t}\right], \ t > 0, \ \theta > 0, \ \lambda > 0$$
 (3.1)

where m and λ are the mean and shape parameters respectively.

Tweedie expressed equation (3.1) in terms of an alternative parameterization, making $\theta = 1/m$, as

$$p(t \mid \theta, \lambda) = \left(\frac{\lambda}{2\pi}\right)^{1/2} t^{-3/2} \exp\left[-\frac{\lambda t}{2} \left(\theta - \frac{1}{t}\right)^2\right], \ t > 0, \ \theta > 0, \ \lambda > 0$$
 (3.2)

we designate equation (3.2) by $IG(\theta,\lambda)$.

Let $\underline{t} = (t_1, ..., t_2)$ be *n* independent complete failure times from $IG(\theta, \lambda)$ with mean $\theta = 1/m$ and known shape parameter λ (>0). The likelihood function is given by

$$L(\theta \mid \underline{t}, \lambda) = \left(\frac{\lambda}{2\pi}\right)^{\frac{n}{2}} \prod_{i=1}^{n} t_i^{-\frac{3}{2}} \exp\left[-\frac{\lambda \nu}{2} - \frac{n\lambda \overline{t}}{2} \left(\theta - \frac{1}{\overline{t}}\right)^2\right]$$
(3.3)

where
$$v = \sum_{i=1}^{n} \left(\frac{1}{t_i} - \frac{1}{\overline{t}} \right)$$
 and $\overline{t} = \sum_{i=1}^{n} t_i / n$.

The reliability for a time period of time t_0 is

$$r(t_o; \theta, \lambda) = 1 - P(T \le t_o) = \Phi\left(\sqrt{\frac{\lambda}{t_o}} (1 - t_o \theta)\right) - e^{2\lambda \theta} \Phi\left(-\sqrt{\frac{\lambda}{t_o}} (1 + t_o \theta)\right)$$
(3.4)

Suppose θ has a prior distribution belonging to ML-II ε-contaminated class of priors, we have $\pi_o(\theta)$ as N(μ , τ), truncated at zero, with pdf

$$\pi_o(\theta) = \frac{1}{G} \sqrt{\frac{\tau}{2\pi}} \exp\left[-\frac{\tau}{2} (\theta - \mu)^2\right]; G = \Phi(-p), p = -\mu \sqrt{\tau}$$

and $\hat{q}(\theta)$ as $Uniform(\mu - \hat{a}, \mu + \hat{a})$, \hat{a} being the value of 'a' which maximizes

$$m(\underline{t} \mid a) = \begin{cases} \frac{1}{2a} \int_{\mu-a}^{\mu+a} L(\theta \mid \underline{t}, \lambda) d\theta & a > 0 \\ L(\mu \mid \underline{t}, \lambda) & a = 0 \end{cases}$$

 $m(\underline{t} \mid a)$ is an upper bound on $m(\underline{t} \mid q)$.

$$m(\underline{t} \mid a) = \left(\frac{\lambda}{2\pi}\right)^{\frac{n}{2}} \prod_{i=1}^{n} t_{i}^{-\frac{3}{2}} e^{-\frac{\lambda \nu}{2}} \sqrt{\frac{2\pi}{n\lambda \overline{t}}} \frac{1}{2a} \int_{\mu-a}^{\mu+a} \sqrt{\frac{n\lambda \overline{t}}{2\pi}} \exp\left[-\frac{n\lambda \overline{t}}{2} \left(\theta - \frac{1}{\overline{t}}\right)^{2}\right] d\theta$$

$$= \frac{S}{2a} \left\{ \Phi\left[\sqrt{n\lambda \overline{t}} \left(\mu + a - \frac{1}{\overline{t}}\right)\right] - \Phi\left[\sqrt{n\lambda \overline{t}} \left(\mu - a - \frac{1}{\overline{t}}\right)\right] \right\}$$
(3.5)

where $S = \left(\frac{\lambda}{2\pi}\right)^{\frac{n}{2}} \prod_{i=1}^{n} t_i^{-\frac{3}{2}} e^{-\frac{\lambda v}{2}} \sqrt{\frac{2\pi}{n\lambda t}}$. On differentiating equation (3.5) with respect to a, we have

$$\frac{d}{da}m(\underline{t}|a) = -\frac{S}{2a^2}\left\{\Phi\left[\sqrt{n\lambda\overline{t}}\left(\mu + a - \frac{1}{\overline{t}}\right)\right] - \Phi\left[\sqrt{n\lambda\overline{t}}\left(\mu - a - \frac{1}{\overline{t}}\right)\right] + \frac{S\sqrt{n\lambda\overline{t}}}{2a}\left\{\Phi\left[\sqrt{n\lambda\overline{t}}\left(\mu + a - \frac{1}{\overline{t}}\right)\right] + \Phi\left[\sqrt{n\lambda\overline{t}}\left(\mu - a - \frac{1}{\overline{t}}\right)\right]\right\}$$

where
$$\phi(\cdot)$$
 denotes standard normal pdf. (3.6)

Now we substitute $z = \sqrt{n\lambda \bar{t}} \left| \frac{1}{\bar{t}} - \mu \right|$ and $a^* = a\sqrt{n\lambda \bar{t}}$ in (3.6) and equate to zero. The equation can be written as

$$a^* = z + \left\{ -2\log\left[\sqrt{2\pi} \left(\frac{1}{a^*} \left[\Phi(a^* - z) - \Phi[-(a^* + z)]\right] - \phi[-(a^* + z)]\right)\right] \right\}^{\frac{1}{2}}$$
 (3.7)

We solve (3.7) by standard fixed-point iteration, set $a^* = z$ on the right-hand side, which gives

$$\widehat{a} = \begin{cases} 0 & \text{if } z \le 1.65 \\ \frac{a^*}{\sqrt{n\lambda \, \overline{t}}} & \text{if } z > 1.65 \end{cases}$$

we make \hat{a} equal to zero when \bar{t} is close to μ .

The usual Bayes point estimate \hat{r} , under quadratic loss function, is the posterior mean of $r(t_o; \theta, \lambda)$

$$\widehat{r} = \int_{\Theta} r(t_o; \theta, \lambda) \pi(\theta \mid \underline{t}, \lambda) d\theta$$

where posterior distribution $\pi(\theta | t, \lambda)$ of parameter θ with respect to prior $\pi(\theta)$ is given by

$$\pi(\theta \mid t, \lambda) = \lambda(t)\pi_{\alpha}(\theta \mid t) + (1 - \lambda(t))q(\theta \mid t)$$
(3.8)

the right hand side terms of equation (3.8) are evaluated as follows

$$\begin{split} & m(\underline{t}\mid\pi_o) = S'\frac{G_1}{G}e^{-\beta} \ ; \ S' = \left(\frac{\lambda}{2\pi}\right)^{\frac{n}{2}} \prod_{i=1}^n t_i^{-\frac{3}{2}} \sqrt{\frac{\tau}{\tau'}} \ , \ G_1 = \Phi\left(-p'\right), p' = -\mu'\sqrt{\tau'}, \\ & m(\underline{t}\mid q) = \frac{S}{2\widehat{a}}\widehat{\phi}_1 \ ; \ \widehat{\phi}_1 = \Phi\left[\sqrt{n\lambda t}\left(\mu + \widehat{a} - \frac{1}{t}\right)\right] - \Phi\left[\sqrt{n\lambda t}\left(\mu - \widehat{a} - \frac{1}{t}\right)\right], \\ & \pi_o(\theta\mid\underline{t}) = \frac{1}{G_1}\sqrt{\frac{\tau'}{2\pi}}\exp\left[-\frac{\tau'}{2}(\theta - \mu')^2\right] \ ; \mu' = \frac{\tau\mu + n\lambda}{\tau'}, \ \tau' = \tau + n\lambda\overline{t}, \\ & q(\theta\mid\underline{t}) = \frac{1}{\widehat{\phi}_1}\sqrt{\frac{n\lambda\overline{t}}{2\pi}}\exp\left[-\frac{n\lambda\overline{t}}{2}\left(\theta - \frac{1}{t}\right)^2\right], \\ & \lambda(\underline{t}) = \left[1 + \frac{\varepsilon}{(1-\varepsilon)}\frac{G}{G_1}\left(\frac{n\lambda\tau\overline{t}}{2\pi\tau'}\right)^{\frac{-1}{2}}\frac{\widehat{\phi}_1e^{\beta'}}{2\widehat{a}}\right]^{-1}, \ \beta = \beta' + \frac{\lambda\nu}{2} \ \text{and} \ \beta' = \frac{n\lambda\tau\overline{t}}{2\tau'}\left(\mu - \frac{1}{t}\right)^2 \ . \end{split}$$

thus

$$\widehat{r} = \int_{0}^{\infty} \int_{t_{o}}^{\infty} \left(\frac{\lambda}{2\pi}\right)^{\frac{1}{2}} t^{-\frac{3}{2}} \exp\left[-\frac{\lambda t}{2} \left(\theta - \frac{1}{t}\right)^{2}\right] \pi_{o}(\theta \mid \underline{t}) dt d\theta + \int_{\mu - \bar{a}}^{\mu + \bar{a}} \int_{t_{o}}^{\infty} \left(\frac{\lambda}{2\pi}\right)^{\frac{1}{2}} t^{-\frac{3}{2}} \exp\left[-\frac{\lambda t}{2} \left(\theta - \frac{1}{t}\right)^{2}\right] q(\theta \mid \underline{t}) dt d\theta$$

$$= \frac{\lambda(\underline{t})}{G_{1}} \left(\frac{\lambda \tau'}{2\pi}\right)^{\frac{1}{2}} \int_{t_{o}}^{\infty} t^{-\frac{3}{2}} \exp\left[-\frac{\lambda \tau' t}{2(\lambda t + \tau')} \left(\frac{1}{t} - \mu'\right)^{2}\right] \phi(\underline{t}) dt + \frac{1 - \lambda(\underline{t})}{\widehat{\phi_{1}}} \left(\frac{n\lambda^{2}\overline{t}}{2\pi}\right)^{\frac{1}{2}} \int_{t_{o}}^{\infty} t^{-\frac{3}{2}} \exp\left[-\frac{n\overline{t}}{2(t + n\overline{t})} \left(\frac{1}{t} - \frac{1}{\overline{t}}\right)^{2}\right] \phi_{1}(\underline{t}) dt$$

$$(3.9)$$

where

$$\begin{split} \phi(\underline{t}) &= \Phi\left(\mu_1 \sqrt{\lambda t + \tau'}\right) \;, \\ \phi_1(\underline{t}) &= \Phi\left[\sqrt{\lambda (t + n\overline{t})} \left(\mu + \widehat{a} - \mu_2\right)\right] - \Phi\left[\sqrt{\lambda (t + n\overline{t})} \left(\mu - \widehat{a} - \mu_2\right)\right], \\ \mu_1 &= \frac{\lambda + \mu' \tau'}{\lambda t + \tau'} \; and \; \mu_2 = \frac{n+1}{t+n\overline{t}}. \end{split}$$

The above two incomplete integrals in equation (3.9) are evaluated through numerical integration.

Lower one-sided Bayes Probability Interval (LBPI) Estimate

We construct $100(1-\alpha)\%$ LBPI estimate r_* of $r(t_o)$ where α is chosen to be a small quantity. Since $r(t_o; \theta, \lambda)$ is a monotonically non-decreasing function of θ for any fixed λ , we have the LBPI estimate of $r(t_o)$ as

$$r_* = \Phi\left(\sqrt{\frac{\lambda}{t_o}} \left(1 - t_o \theta^*\right)\right) - e^{2\lambda \theta^*} \Phi\left(-\sqrt{\frac{\lambda}{t_o}} \left(1 + t_o \theta^*\right)\right)$$
(3.10)

where θ^* is the 100(1- α)% LBPI estimate of θ and is evaluated as

$$\begin{split} &P(\theta \geq \theta^*) = \alpha \\ & \iint\limits_{\theta^*} \pi(\theta \mid \underline{t}, \lambda) d\theta = \alpha \\ & \lambda(\underline{t}) \int\limits_{\theta^*}^{\infty} \pi_o(\theta \mid \underline{t}) d\theta + (1 - \lambda(\underline{t})) \int\limits_{\theta^*}^{\mu + \overline{a}} q(\theta \mid \underline{t}) d\theta = \alpha \\ & \frac{\lambda(\underline{t})}{G_1} \Phi\left(-\sqrt{\tau'}(\theta^* - \mu')\right) - \frac{(1 - \lambda(\underline{t}))}{\widehat{\phi_1}} \Phi\left(\sqrt{n\lambda \overline{t}} \left(\theta^* - \frac{1}{\overline{t}}\right)\right) = \alpha - \frac{(1 - \lambda(\underline{t}))}{\widehat{\phi_1}} \Phi\left(\sqrt{n\lambda \overline{t}} \left(\mu + \widehat{a} - \frac{1}{\overline{t}}\right)\right) \end{split}$$

We evaluate θ^* using Matlab for a given α and substitute in r_* to obtain the required LBPI for varying \int .

4. Illustration

In order to study sensitivity of the Bayes reliability measure to the ML-II \int contaminated prior for lognormal distribution we consider two sets of data. Data-Set 1 is the failure times (in hours) of the air conditioning system of 30 different airplanes obtained from Linhardt and Zucchini (1986). The data on active repair time (hours) are

Data-Set 2 is considered from Barlow, Toland and Freeman (1979). It represents the failure times on pressure vessels that were tested at 4300 psi. The complete ordered failure times were reported to be

The precision ψ assumed known; we take its ML estimate as its true value. The subjective estimates of the parameters of the prior distribution are made on the basis of the above experiment.

For the inverse Gaussian distribution we again consider two sets of data. Data-Set 3 is a simulated random sample of size n = 30 from IG population using algorithm given in Devrorye (1986, page 149).

Data-Set 4 is considered from Nadas (1973). Certain electronic device having thin film metal conductors fail due to mass depletion at a centre location on the conductor. The life time of such a device is the time elapsed until a critical amount of mass is depleted from the critical location. A sample of devices was tested under high stress conditions until all of them failed. There were n = 10 of them that were found to have failed due to mass depletion at the critical location. The corresponding lifetimes are summarized by the

sufficient statistics
$$\overline{t} = 1.352$$
 and $\overline{t_r} = \left[\frac{1}{n}\left(\sum_{i=1}^n t_i^{-1}\right)\right]^{-1} = 0.948$.

The prior parameter μ has been taken to be approximately equal to the reciprocal of median of the $IG(\theta,\lambda)$ and precision τ equal to the reciprocal of the ML estimate of the variance. The value of known shape parameter λ is taken to be the ML estimate of

$$\widehat{\lambda} = \left(\frac{n}{n-1} \left(\frac{1}{\overline{t_r}} - \frac{1}{\overline{t}}\right)\right)^{-1}.$$

The Kolmogorov-Smirnov test statistic for the above three data-sets and the graphs of empirical and the theoretical curves are given in Appendix 1. The results show that LN and IG is a good fit for all the above data-sets.

Bayesian Results for Lognormal Distribution

Data-Set 1

Table 1
n = 30,
$$\psi$$
 = 0.5746, μ = 4, t_o = 10 hrs

Comparative values of Bayes reliability estimate for varying τ , ε

τ	0	0.05	0.2	0.5	0.9
0.01	0.784468	0.790316	0.795805	0.798426	0.799452
0.5	0.788418	0.789431	0.792010	0.795732	0.798973
0.9	0.791458	0.792068	0.793720	0.796390	0.799044

Table 2 Comparative values of Bayes LBPI (α = 0.05) estimate for varying τ , ϵ

τ	0	0.05	0.2	0.5	0.9
0.01	0.691529	0.717544	0.731520	0.736646	0.738472
0.5	0.697696	0.704984	0.717890	0.729984	0.737472
0.9	0.702446	0.708018	0.718791	0.729904	0.737421

Table 3 $R{=}0.8$ Comparative values of Bayes Reliable Life estimate for varying $\tau,\,\epsilon$

τ	0	0.05	0.2	0.5	0.9
0.01	9.749040	9.961537	10.161031	10.256270	10.293567
0.5	9.915409	9.950159	10.038584	10.166237	10.277391
0.9	10.046511	10.065425	10.116626	10.199404	10.281663

Data-Set 2

Table 4 $n=39,\,\psi=0.2430,\,\mu=5,\,\,t_{\it o}=100\,\,hrs$ Comparative values of Bayes reliability estimate for varying $\tau,\,\epsilon$

τ	0	0.05	0.2	0.5	0.9
0.01	0.398877	0.403509	0.409064	0.412279	0.413661
0.5	0.407347	0.407824	0.409125	0.411255	0.413407
0.9	0.413704	0.413713	0.413741	0.413790	0.413843

Table~5 Comparative values of Bayes LBPI (\$\alpha = 0.05) estimate for varying \$\tau\$, \$\epsilon\$

τ	0	0.05	0.2	0.5	0.9
0.01	0.214924	0.218005	0.224116	0.230643	0.235195
0.5	0.310689	0.315118	0.324176	0.334029	0.340984
0.9	0.318360	0.321578	0.328239	0.335787	0.341248

Table 6 R=0.8 Comparative values of Bayes Reliable Life estimate for varying $\tau,\,\epsilon$

τ	0	0.05	0.2	0.5	0.9
0.01	11.292092	11.527624	11.810116	11.973591	12.043886
0.5	11.784220	11.803980	11.857837	11.946058	12.035160
0.9	12.165426	12.158146	12.137635	12.101767	12.062352

Tables 1-6 suggest that the Bayes reliability, LBPI and reliable life for lognormal distribution are not sensitive to contamination in the ML-II priors. We observe insignificant variation in the above Bayes reliability measures for both the data-sets 1 and 2 for varying precision, τ , and contamination, ϵ .

Bayesian Results for Inverse Gaussian Distribution

Data-Set 3

Table 7
$$n = 30$$
, $\mu = 2.1450$, $\lambda = 2.6339$, $t_a = 5$

Comparative values of Bayes reliability estimate for varying τ , ϵ

τ	0	0.05	0.2	0.5	0.9
0.01	0.269713	0.264824	0.261595	0.260360	0.259918
0.0284	0.269700	0.266013	0.262418	0.260654	0.259955
0.5	0.269356	0.267964	0.265091	0.262088	0.260173

Table 8 $\alpha = 0.05$ Comparative values of Bayes LBPI estimate for varying $\tau, \, \epsilon$

τ	0	0.05	0.2	0.5	0.9
0.01	0.182376	0.181409	0.180798	0.180571	0.180491
0.0284	0.182367	0.181636	0.180951	0.180624	0.180498
0.5	0.182135	0.181882	0.181373	0.180854	0.180531

Data-Set 4

Table 9
n = 10,
$$\mu$$
 = 0.5, λ = 4.8077, t_o = 0.5

Comparative values of Bayes reliability estimate for varying τ , ϵ

τ	0	0.05	0.2	0.5	0.9
0.01	0.958766	0.961729	0.964049	0.965030	0.965395
0.05	0.958787	0.960600	0.963047	0.964623	0.965341
0.5	0.959022	0.959815	0.961597	0.963698	0.965188

Table 10 $\alpha = 0.05$ Comparative values of Bayes LBPI estimate for varying $\tau, \, \epsilon$

ε	0	0.05	0.2	0.5	0.9
0.01	0.927384	0.942010	0.947220	0.948853	0.949405
0.05	0.927389	0.938207	0.945238	0.948201	0.949323
0.5	0.927920	0.934339	0.939898	0.941203	0.940146

The Bayes reliability measures are insensitive to contaminations in the ML-II prior. Tables 7-10 suggest insignificant variation in Bayes reliability and LBPI for both the data-sets 3 and 4 for varying precision, τ , and contamination, ϵ , in the ML-II prior.

5. Conclusion

The numerical illustrations suggest that reasonable amount of misspecification in the prior distribution belonging to the class of ML-II ε-contaminated does not affect the Bayesian reliability measures for lognormal and inverse Gaussian distributions. The mathematical results obtained in Section 2 and 3 play down the effect of subjective choice of prior for the unknown parameters of both the distributions considered.

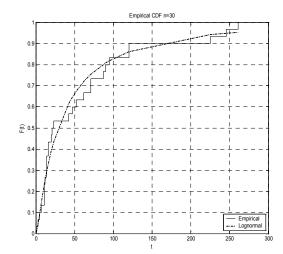
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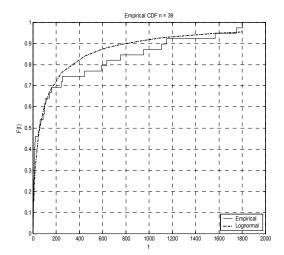
- Aase, K.K. (2000). An equilibrium asset pricing model based on Levy processes: relations to stochastic volatility and the survival hypothesis. *Insurance Mathematics and Economics*, 27, 345-363.
- Aitchison, J. and Brown, J. (1957). The Lognormal Distribution. Cambridge University Press.
- Banerjee, A.K. and Bhattacharyya, G.K. (1976). A purchase incidence model with inverse Gaussian interpurchase times. *J. Amer. Statist. Assoc.*, 71, 823-829.
- Banerjee, A.K. and Bhattacharyya, G.K. (1979). Bayesian results for the inverse Gaussian distribution with an application. *Techonometrics*, 21, 247-251.
- Bansal, A.K. and Sinha, P. (2008). Bayesian optimization analysis with ML-II € contaminated prior. *Journal of Applied Statistics*, 35, 203-211.

- Barlow, R.E., Toland, R.H., and Freeman, T. (1979). Stress rupture life of Kevlar/Epoxy spherical pressure vessels, UCID-1755 Part 3, Lawrence Livermore Laboratory, Livermore, CA.
- Berger, J.O. (1984). The robust Bayesian viewpoint (with discussion). In *Robustness of Bayesian Analysis*, J. Kadane (Ed.), North Holland, Amsterdam, 63-124.
- Berger, J.O. (1985). Statistical Decision Theory and Bayesian Analysis. Springer-Verlag, New York.
- Berger, J.O. (1990). Robust Bayesian analysis: sensitivity to the prior. *Journal of Statistical Planning and Inference*, 25, 303-323.
- Berger, J.O. (1994). An overview of robust Bayesian analysis. *Test*, 5-59.
- Berger, J.O. and Berlinear, M. (1986). Robust Bayes and empirical Bayes analysis with € contaminated priors. *Annals of Statistics*, 14, 461-486.
- Berger, J.O. and Sellke, T. (1987). Testing a point null hypothesis: The irreconcilability of p values and evidence. *J. Amer. Statist. Assoc.*, 82,112-139.
- Blishke, W. and Murthy D. (2000). Reliability: Modeling, Prediction, and Optimization, Wiley.
- Chhikara, R.S. and Folks, J.L. (1989). *The Inverse Gaussian distribution*. Marcel Decker, Inc., New York.
- Chhikara, R.S. and Folks, J.L. (1977). The Inverse Gaussian distribution as a life-time model. *Technometrics*, 19, 461–468.
- Devroye, L. (1986). Non-Uniform Random Variate Generation. Springer-Verlag, New York.
- Good, I.J. (1965). The Estimation of Probabilities. MIT Press, Cambridge, MA.
- Linhardt, H. and Zucchini, W. (1986). *Model Selection*. New York: Wiley.
- Martín, J. and Pérez, C.J. (2009). Bayesian analysis of a generalized lognormal distribution. *Computational Statistics and Data Analysis*, 53, 1377-1387.
- Martz, F.H. and Waller, A.R. (1982). *Bayesian Reliability Analysis*. New York: Wiley.
- Nadarajha, S. and Kotz, S. (2007). Inverse Gaussian random variables with application to price indices. Applied Economics Letters, 14, 673-677.
- Nadas, A. (1973). Best tests for zero drift based first passage times in Brownian motion. *Technometrics*, *15*, *125-132*.

- Seshadri, V. (1999). The Inverse Gaussian Distribution, Statistical Theory and application. Springer-Verlag, New York.
- Whitemore, G.A. (1976). Management applications of the inverse Gaussian distributions. *Int. J. Manage. Sci.*, 4, 215-223.
- Whitemore, G.A. (1986). Inverse Gaussian ratio estimation. Applied Statistics, 35, 8-15.

Appendix 1





at 5% 0.05

Kolmogorov – Smirnov Test and p sig. values Decision k-s p 0.8794 0.1047 Data fits LN n=30Data fits LN 0.1605 0.2450 n=39

Empirical CDF n = 30

Kolmogorov – Smirnov Test and p sig. values Decision at 5% k-s 0.05 0.4472 n=30 0.1535 Data fits IG